Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/749,533	HWANG ET AL.		
Examiner	Art Unit		
Steven H. Rao	2814		

	SEARCHED					
Class	Subclass	Date	Examiner			
438	210	1/23/2007	SR			
438	255	1/23/2007	SR			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
438	210	1/23/2007	SR	
438	255	1/23/2007	SR	
(storage with node) and semiconductor and (SAC or (self w		1/23/2007	SR	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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